

CERTIFICATION TEST REPORT

Report Number : 4790173298-FR2V1

Applicant : Samsung Electronics Co.,Ltd. 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do 16677, Korea

Model : WBA210M

FCC ID	:	A3LWBA210M		
IC	:	649E-WBA210M		

- EUT Description : BLE Transceiver
- Test Standard(s) : FCC 47 CFR PART 1 SUBPART I FCC 47 CFR PART 2 SUBPART J INDUSTRY CANADA RSS 102 ISSUE 5

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Prepared by:

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REPORT REVISION HISTORY

Rev.	Issue Date	Revisions	Revised By
V1	11/18/21	Initial issue	Robby Lee

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1. ATTESTATION OF TEST RESULTS

COMPANY NAME: Samsung Electronics Co.,Ltd.

EUT DESCRIPTION: BLE Transceiver

MODEL: WBA210M

Serial Number: Proto type

DATE TESTED: 2021-11-04

APPLICABLE STANDARDS						
STANDARD	TEST RESULTS					
FCC PART 1 SUBPART I						
FCC PART 2 SUBPART J	Complies					
INDUSTRY CANADA RSS 102 ISSUE 5						

UL Korea, Ltd. tested the above equipment in accordance with the requirements set forth in the above standards. All indications of Pass/Fail in this report are opinions expressed by UL Korea, Ltd. based on interpretations and/or observations of test results. Measurement Uncertainties were not taken into account and are published for informational purposes only. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

Note: The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. This document may not be altered or revised in any way unless done so by UL Korea, Ltd. and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL Korea, Ltd. will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by IAS, any agency of the Federal Government, or any agency of any government.

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UL Korea, Ltd. Suwon Laboratory 218 Maeyeong-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16675, Korea TEL: (031) 337-9902 FAX: (031) 213-5433 UL Korea, Ltd. Confidential

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2. TEST METHODOLOGY

All calculations were made in accordance with FCC OET Bulletin 65 Edition 97-01 and IC Safety Code 6.

3. FACILITIES AND ACCREDITATION

The test sites and measurement facilities used to collect data are located at 218 Maeyeong-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16675, Korea. Line conducted emissions are measured only at the 218 address. The following table identifies which facilities were utilized for radiated emission measurements documented in this report. Specific facilities are also identified in the test results sections.

218 Maeyeong-ro	
Shield Room 5	

UL Korea, Ltd. is accredited by IAS, Laboratory Code TL-637. The full scope of accreditation can be viewed at <u>https://www.iasonline.org/wp-content/uploads/2017/05/TL-637-cert-New.pdf</u>.

4. EQUIPMENT UNDER TEST

4.1. DESCRIPTION OF EUT

The EUT is a BLE Transceiver.

4.2. DESCRIPTION OF AVAILABLE ANTENNAS

The radio utilizes a internal antenna for the [List the bands supported] with a maximum peak gain as follow:

Frequency (MHz)	Allowed Max. Peak Gain (dBi)
2402 ~ 2480	1.35

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5. MAXIMUM PERMISSIBLE RF EXPOSURE

5.1. FCC LIMITS

§1.1310 The criteria listed in Table 1 shall be used to evaluate the environmental impact of human exposure to radio-frequency (RF) radiation as specified in §1.1307(b), except in the case of portable devices which shall be evaluated according to the provisions of §2.1093 of this chapter.

Frequency range (MHz)	Electric field strength (V/m)	Power density (mW/cm ²)	Averaging time (minutes)	
	(A) Limits for Oc	cupational/Controlled Ex	posure	
0.3-3.0	614	1.63	*100	6
3.0-30	1842/f	4.89/f	*900/f ²	6
30-300	61.4	0.163	1.0	6
300-1,500			f/300	6
1,500-100,000			5	6
	(B) Limits for Genera	al Population/Uncontrolled	d Exposure	
0.3-1.34	614	1.63	*100	30
1.34-30	824/f	2.19/f	*180/f ²	30
30-300	27.5	0.073	0.2	30
300-1,500			f/1500	30
1,500-100,000			1.0	30

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

f = frequency in MHz

* = Plane-wave equivalent power density

Notes:

- (1) Occupational/controlled exposure limits apply in situations in which persons are exposed as a consequence of their employment provided those persons are fully aware of the potential for exposure and can exercise control over their exposure. Limits for occupational/controlled exposure also apply in situations when a person is transient through a location where occupational/controlled limits apply provided he or she is made aware of the potential for exposure.
- (2) General population/uncontrolled exposure limits apply in situations in which the general public may be exposed, or in which persons who are exposed as a consequence of their employment may not be fully aware of the potential for exposure or cannot exercise control over their exposure

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5.2. IC RULES

IC Safety Code 6 (2015), Section 2.2.2: To ensure compliance with the basic restrictions outlined in Section 2.1, at frequencies between 10 MHz and 300 GHz, the reference levels for electric- and magnetic-field strength and power density must be complied with.

TABLE 5: Reference Levels for Electric Field Strength, Magnetic Field Strength and Power	
Density in Uncontrolled Environments	

Frequency (MHz)	Electric Field Strength (E _{RL}), (V/m, RMS)	Magnetic Field Strength (H _{RL}), (A/m, RMS)	Power Density (S _{RL}), (W/m²)	Reference Period (minutes)
10 - 20	27.46	0.0728	2	6
20 - 48	58.07 / f ^{0.25}	0.1540 / f ^{0.25}	8.944 / f ^{0.5}	6
48 - 300	22.06	0.05852	1.291	6
300 - 6000	3.142 f ^{0.3417}	0.008335 <i>f</i> ^{0.3417}	0.02619 <i>f</i> ^{0.6834}	6
6000 -15000	61.4	0.163	10	6
15000 - 150000	61.4	0.163	10	616000 / f ^{1.2}
150000 - 300000	0.158 <i>f</i> ^{0.5}	4.21×10 ⁻⁴ f ^{0.5}	6.67×10⁻⁵ <i>f</i>	616000 / f ^{1.2}
Frequency, <i>f</i> , is	s in MHz.			

TABLE 6: Reference Levels for Electric Field Strength, Magnetic Field Strength and Power Density in Controlled Environments

Electric Field Strength (E _{RL}), (V/m, RMS)	Magnetic Field Strength (H _{RL}), (A/m, RMS)	Power Density (S _{RL}), (W/m²)	Reference Period (minutes)
61.4	0.163	10	6
129.8 / f ^{0.25}	0.3444 / f ^{0.25}	44.72 / f ^{0.5}	6
49.33	0.1309	6.455	6
15.60 f ^{0.25}	0.04138 <i>f</i> ^{0.25}	0.6455 f ^{0.5}	6
137	0.364	50	6
137	0.364	50	616000 / f ^{1.2}
0.354 f ^{0.5}	9.40×10 ⁻⁴ f ^{0.5}	3.33×10 ⁻⁴ f	616000 / f ^{1.2}
	(E _{RL}), (V/m, RMS) 61.4 129.8 / f ^{0.25} 49.33 15.60 f ^{0.25} 137 137	(E _{RL}), (V/m, RMS)(H _{RL}), (A/m, RMS) 61.4 0.163 $129.8 / f^{0.25}$ $0.3444 / f^{0.25}$ 49.33 0.1309 $15.60 f^{0.25}$ $0.04138 f^{0.25}$ 137 0.364	(E _{RL}), (V/m, RMS)(H _{RL}), (A/m, RMS)(S _{RL}), (W/m²) 61.4 0.163 10 $129.8 / f^{0.25}$ $0.3444 / f^{0.25}$ $44.72 / f^{0.5}$ 49.33 0.1309 6.455 $15.60 f^{0.25}$ $0.04138 f^{0.25}$ $0.6455 f^{0.5}$ 137 0.364 50 137 0.364 50

Notes for Tables 5 and 6:

1. For exposures shorter than the reference period, field strengths may exceed the reference levels, provided that the time average of the squared value of the electric or magnetic field strength over any time period equal to the reference period shall not exceed ERL2 or HRL2, respectively. For exposures longer than the reference period, including indefinite exposures, the time average of the squared value of the electric or magnetic field strength over any time period equal to the reference period. Start any time period equal to the reference period shall not exceed ERL2 or HRL2, respectively. For exposures of the electric or magnetic field strength over any time period equal to the reference period shall not exceed ERL2 or HRL2, respectively.

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5.3. EQUATIONS

POWER DENSITY

Power density is given by:

 $S = EIRP / (4 * Pi * D^2)$

Where

S = Power density in mW/cm² EIRP = Equivalent Isotropic Radiated Power in mW D = Separation distance in cm

Power density in units of mW/cm² is converted to units of W/m² by multiplying by 10.

DISTANCE

Distance is given by:

D = SQRT (EIRP / (4 * Pi * S))

Where

D = Separation distance in cm EIRP = Equivalent Isotropic Radiated Power in mW S = Power density in mW/cm²

SOURCE-BASED DUTY CYCLE

Where applicable (for example, multi-slot cell phone applications) a duty cycle factor may be applied.

Source-based time-averaged EIRP = (DC / 100) * EIRP

Where

DC = Duty Cycle in %, as applicable EIRP = Equivalent Isotropic Radiated Power in W

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5.4. IC EXEMPTION

INDUSTRY CANADA EXEMPTION

RSS-102 Clause 2.5.2 RF exposure evaluation is required if the separation distance between the user and the device's radiating element is greater than 20 cm, except when the device operates as follows:

- below 20 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 1 W (adjusted for tune-up tolerance);
- at or above 20 MHz and below 48 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 22.48/f0.5W (adjusted for tune-up tolerance), where *f* is in MHz;
- at or above 48 MHz and below 300 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 0.6 W (adjusted for tune-up tolerance);
- at or above 300 MHz and below 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 1.31 x 10-2 *f* 0.6834 W (adjusted for tune-up tolerance), where *f* is in MHz;
- at or above 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 5 W (adjusted for tune-up tolerance).

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6. TEST RESULTS

6.1. **RF EXPOSURE**

In the table(s) below, Power and Gain are entered in units of dBm and dBi respectively and conversions to linear forms are used for the calculations.

RF function or Mode	•	ency MHz	range z)	Max Target Power (dBm)	ANT Gain (dBi)	Calculated EIRP (dBm)	Maximum EIRP (dBm)	Maximum EIRP (mW)	Maximum power density (mW/cm ²)	FCC Requriment (mW/cm²)	ISED Requriment (W/cm²)
BLE	2402.00	~	2480.00	8.50	1.35	9.85	9.85	9.661	0.002	1.000	5.351

Note 1: The EUT will only be used with a separation of 20 centimeters or greater between the antenna and the body of the user. Note 2: Max. EIRP [dBm] = Max. Target Power [dBm] + Antenna Gain [dBi]

END OF TEST REPORT

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